

# MOS FIELD EFFECT TRANSISTOR NP32N055HLE, NP32N055ILE

# **SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE**

#### **DESCRIPTION**

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

#### **FEATURES**

- Channel temperature 175 degree rated
- Super low on-state resistance

RDS(on)1 = 24 m $\Omega$  MAX. (VGS = 10 V, ID = 16 A)

RDS(on)2 = 29 m $\Omega$  MAX. (VGS = 5.0 V, ID = 16 A)

- Low Ciss : Ciss = 1300 pF TYP.
- Built-in gate protection diode

#### **ORDERING INFORMATION**

PART NUMBER	PACKAGE		
NP32N055HLE	TO-251		
NP32N055ILE	TO-252		

(TO-251)





# ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	Drain to Source Voltage	Voss	55	V
	Gate to Source Voltage	Vgss	±20	V
	Drain Current (DC)	D(DC)	±32	Α
*	Drain Current (Pulse) Note1	D(pulse)	±100	Α
	Total Power Dissipation (T <sub>A</sub> = 25°C)	Рт	1.2	W
	Total Power Dissipation (Tc = 25°C)	Рт	66	W
	Single Avalanche Current Note2	las	28 / 21 / 8	Α
	Single Avalanche Energy Note2	Eas	7.8 / 44 / 64	mJ
	Channel Temperature	$T_ch$	175	°C
	Storage Temperature	T <sub>stg</sub>	-55 to +175	°C

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1 %

**2.** Starting T<sub>ch</sub> = 25°C, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20 V $\rightarrow$ 0 V (See Figure 4.)

# THERMAL RESISTANCE

May 2000 NS CP(K)

Channel to Case	Rth(ch-C)	2.27	°C/W
Channel to Ambient	Rth(ch-A)	125	°C/W

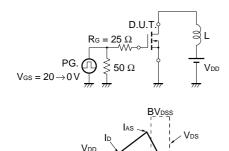
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# **ELECTRICAL CHARACTERISTICS (TA = 25 °C)**

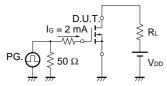
	CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
	Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 16 A		19	24	mΩ
		RDS(on)2	Vgs = 5.0 V, ID = 16 A		22	29	mΩ
		RDS(on)3	Vgs = 4.5 V, ID = 16 A		24	33	mΩ
	Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	1.5	2	2.5	V
	Forward Transfer Admittance	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 16 A	8	16		s
	Drain Leakage Current	IDSS	V <sub>DS</sub> = 55 V, V <sub>GS</sub> = 0 V			10	μΑ
	Gate to Source Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
	Input Capacitance	Ciss	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1300	2000	pF
	Output Capacitance	Coss			180	270	pF
	Reverse Transfer Capacitance	Crss			90	160	pF
*	Turn-on Delay Time	td(on)	ID = 16  A, VGS(on) = 10  V, VDD = 28  V,		14	31	ns
*	Rise Time	tr	$R_G = 1 \Omega$		8	20	ns
*	Turn-off Delay Time	td(off)			40	81	ns
*	Fall Time	tf			7.4	19	ns
	Total Gate Charge	Q <sub>G1</sub>	ID = 32 A, VDD = 44 V, VGS = 10 V		27	41	nC
		Q <sub>G2</sub>	ID = 32 A, VDD = 44 V, VGS = 5.0 V		15	23	nC
	Gate to Source Charge	Qgs			5		nC
	Gate to Drain Charge	Q <sub>GD</sub>			9		nC
	Body Diode Forward Voltage	V <sub>F</sub> (S-D)	IF = 32 A, VGS = 0 V		1.0		V
	Reverse Recovery Time	trr	$I_F = 32 \text{ A}, \text{ Vgs} = 0 \text{ V}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		41		ns
	Reverse Recovery Charge	Qrr			58		nC

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

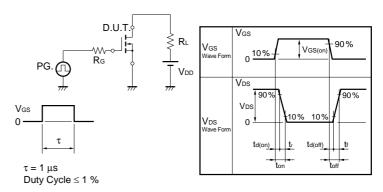


-Starting Tch

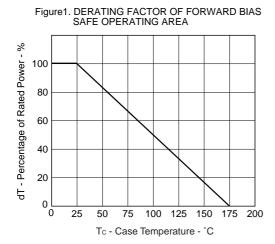


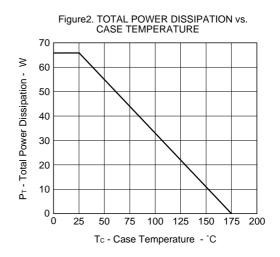


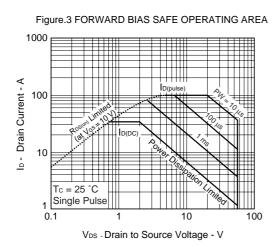
#### **TEST CIRCUIT 2 SWITCHING TIME**

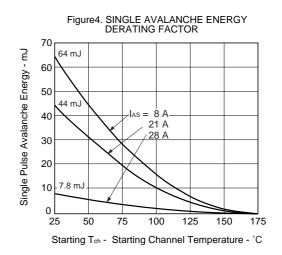


### **★** TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C)









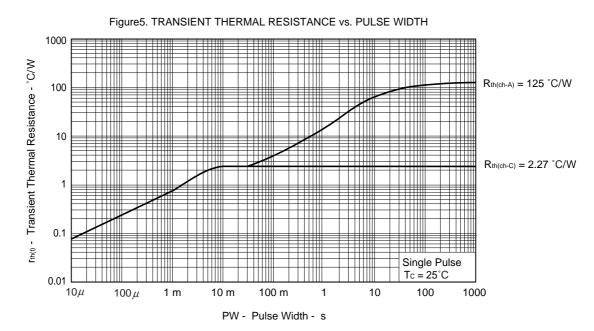


Figure 6. FORWARD TRANSFER CHARACTERISTICS

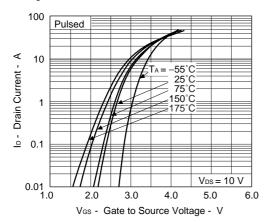


Figure 7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

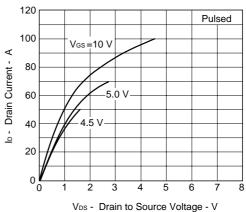


Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

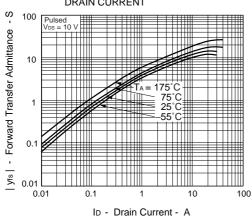


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

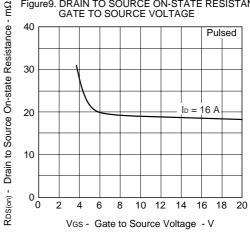


Figure 10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT Ш 80

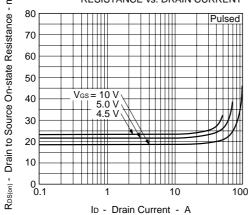
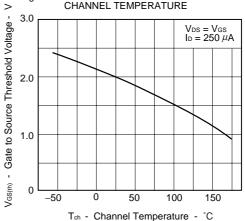
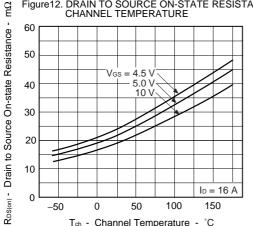
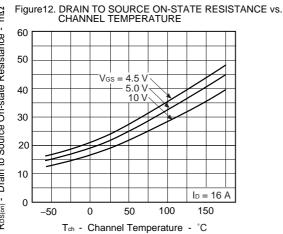
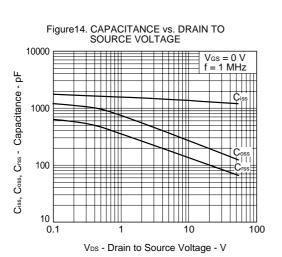


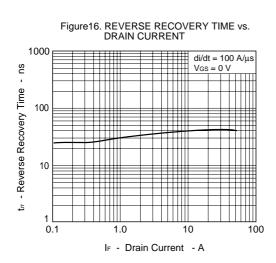
Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE

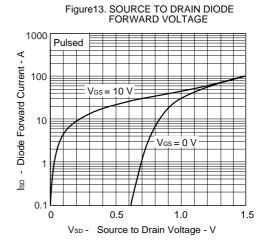


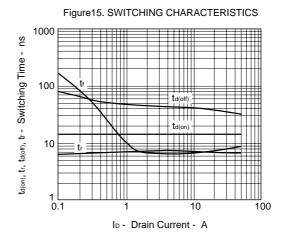


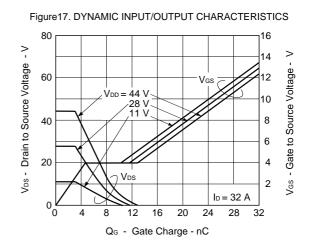






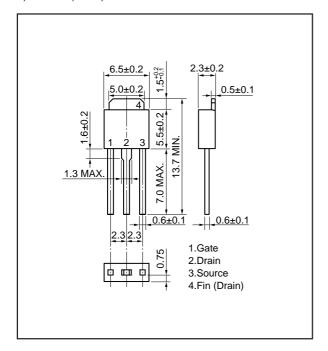




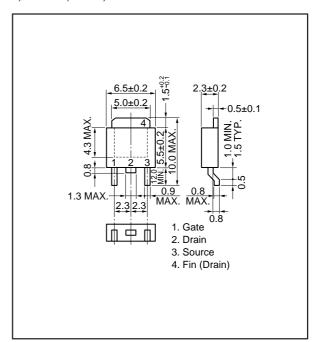


# PACKAGE DRAWINGS (Unit: mm)

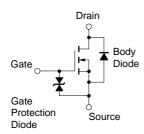
#### 1) TO-251 (MP-3)



#### 2) TO-252 (MP-3Z)



#### **EQUIVALENT CIRCUIT**



# **Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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